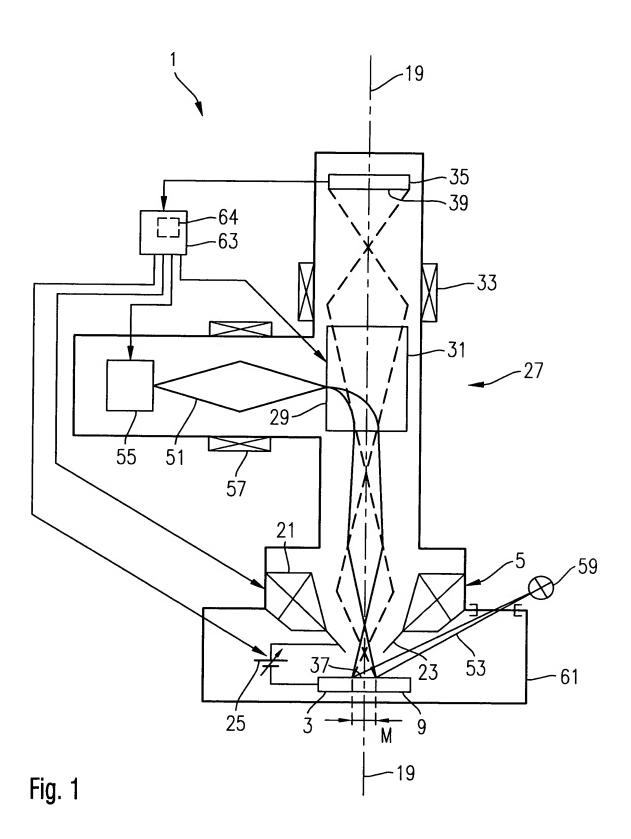
**APPLN. FILING DATE:** JULY 9, 2003 **TITLE:** METHOD FOR THE ELECTRON-MICROSCOPIC OBSERVATION OF A SEMICONDUCTOR ARRANGEMENT ...

**INVENTOR(S):** OLIVER KIENZLE ET AL.

**APPLICATION SERIAL NO: 007413-056** 

SHEET 1 of 9



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INVENTOR(S): OLIVER KIENZLE ET AL.

SHEET 2 of 9 **APPLICATION SERIAL NO: 007413-056** 

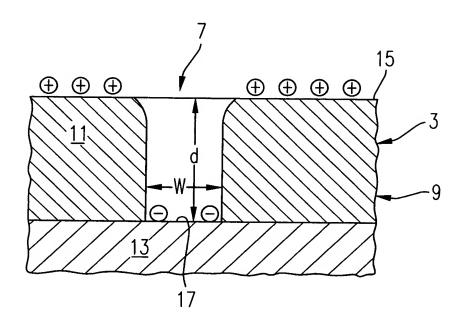


Fig. 2

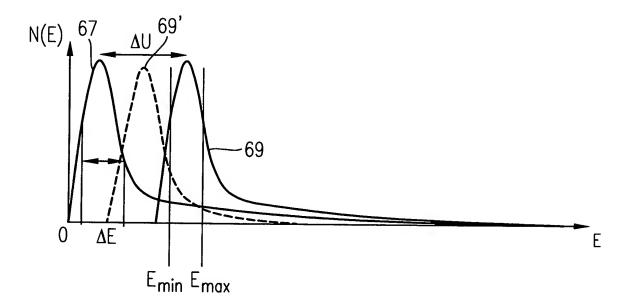
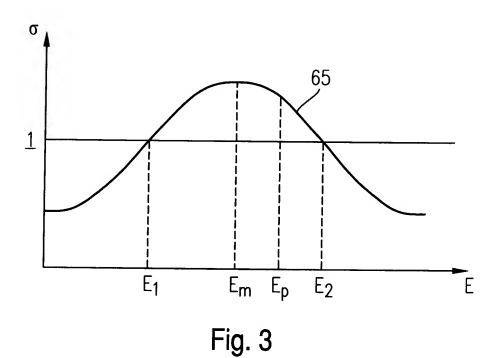


Fig. 4

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σ 65 1 E  $E_{\rm m}^{\rm a} E_{\rm 1}^{\rm b} E_{\rm s} E_{\rm 2}^{\rm a} E_{\rm m}^{\rm b} E_{\rm p}$ 

Fig. 8

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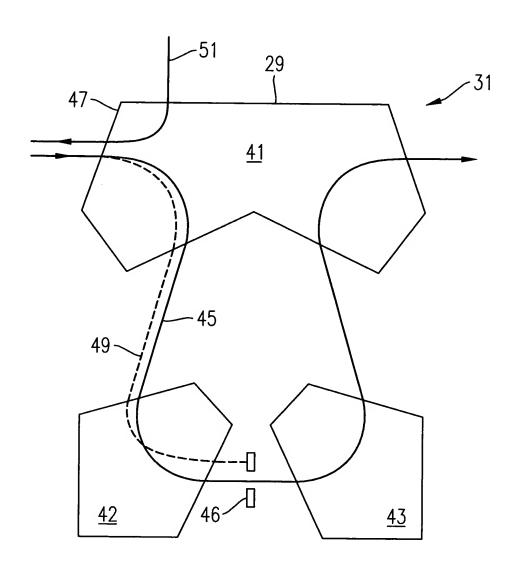
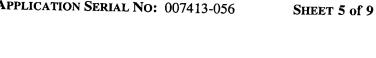


Fig. 5

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SHEET:



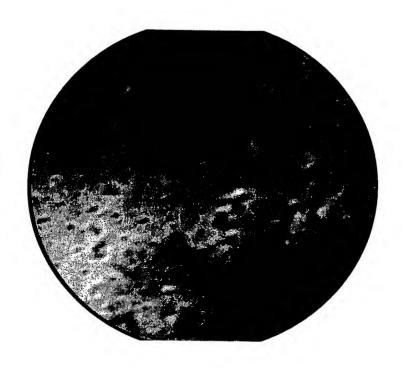


Fig. 6

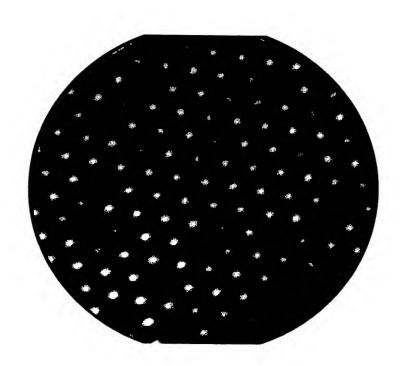


Fig. 7

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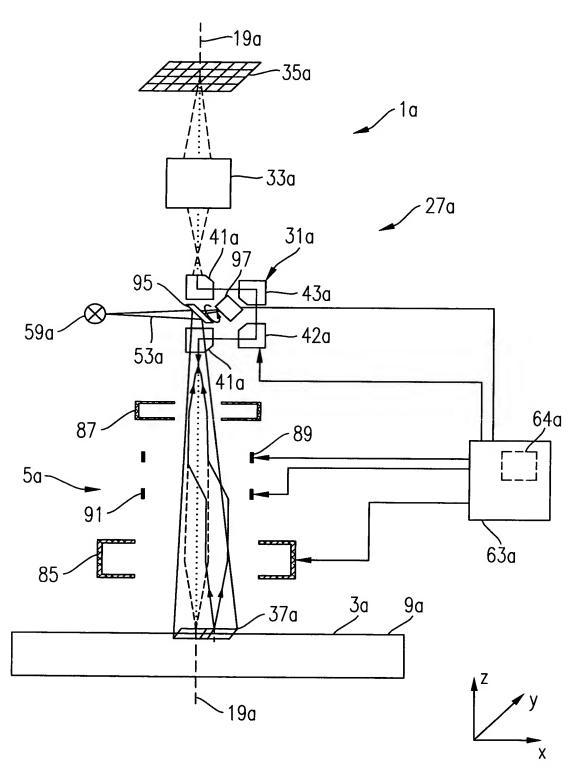


Fig. 9

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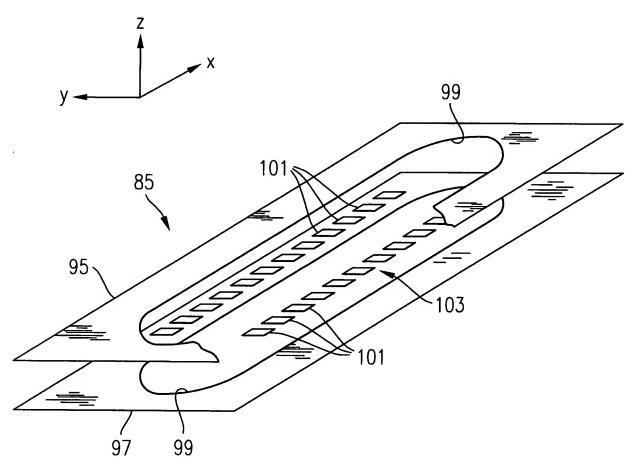


Fig. 10

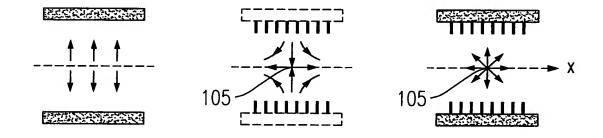


Fig. 11a

Fig. 11b

Fig. 11c

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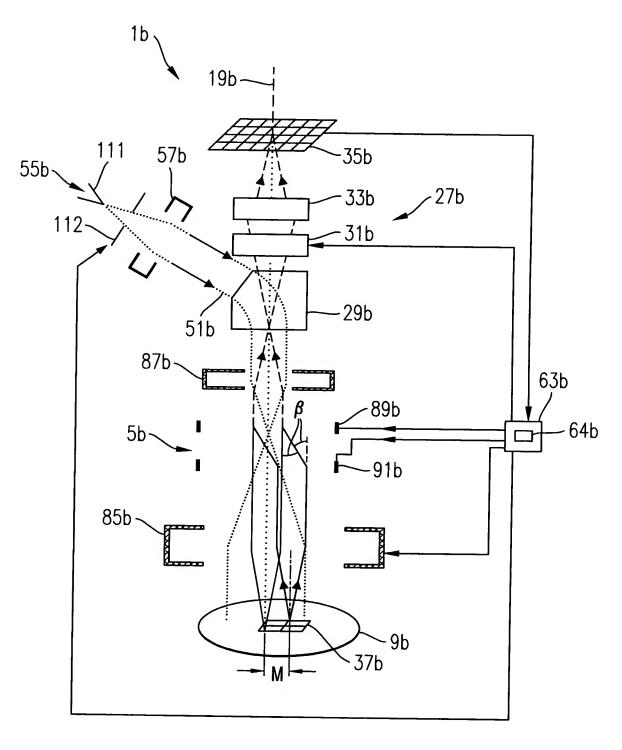


Fig. 12



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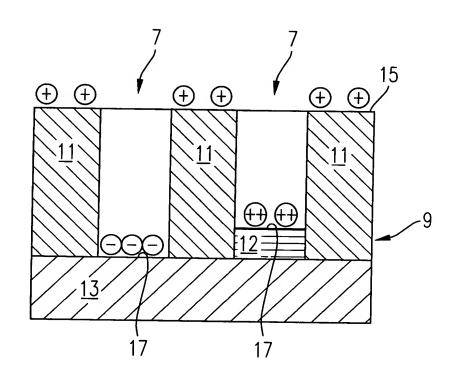


Fig. 13a

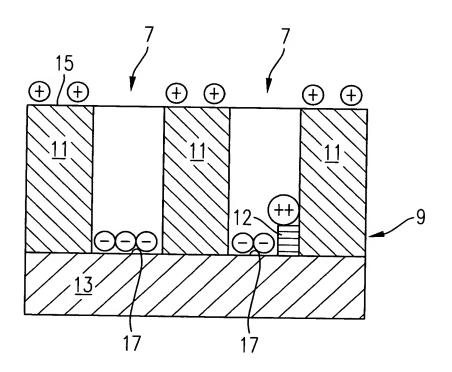


Fig. 13b